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- State-of-the-Art *EPIC*-II*B*[™] BiCMOS Design Significantly Reduces Power Dissipation
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Typical V_{OLP} (Output Ground Bounce) < 1 V at V_{CC} = 5 V, T_A = 25°C
- High-Drive Outputs (–32-mA I_{OH}, 64-mA I_{OL})
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Plastic (N) and Ceramic (J) DIPs, and Ceramic Flat (W) Package

description

These 8-bit flip-flops feature 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. They are particularly suitable for implementing buffer registers, I/O ports, bidirectional bus drivers, and working registers.

The eight flip-flops of the SN54ABT374 and SN74ABT374A are edge-triggered D-type flip-flops. On the positive transition of the clock (CLK) input, the Q outputs are set to the logic levels set up at the data (D) inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without need for interface or pullup components. \overline{OE} does not affect internal operations of the flip-flop. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54ABT374 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ABT374A is characterized for operation from -40° C to 85° C.



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SN54ABT374 J OR W PACKAGE
SN74ABT374A DB, DW, N, OR PW PACKAGE
(TOP VIEW)

	(101	vi L)	
OE 1Q 1D 2D 2Q 3Q 3D 4D	2 3 4 5 6 7	18 17 16 15 14	V _{CC} 8Q 8D 7D 7Q 6Q 6D 5D
4D	8	13	5D
4D 4Q GND	9		5D 5Q CLK
GND		- 11	I ULK

SN54ABT374 . . . FK PACKAGE (TOP VIEW)

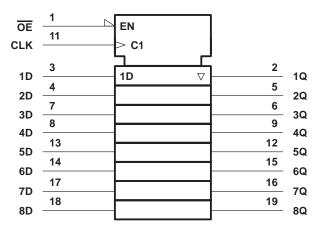
	0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	۲ ۵	
		β	
2D		18 [8D
2Q	5	17	7D
2D 2Q 3Q 3D 4D	6	16	7Q
3D	7	15	6Q
4D	8	14	6D
		3	
	GND 50 50 50 1 50 1 50	50	I

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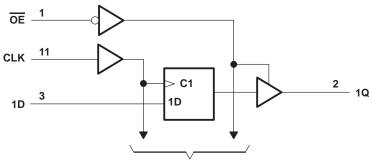
FUNCTION TABLE (each flip-flop)									
	INPUTS	OUTPUT							
OE	CLK	D	Q						
L	\uparrow	Н	Н						
L	\uparrow	L	L						
L	H or L	Х	Q ₀						
Н	Х	Х	Z						

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Channels



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} Input voltage range, V _I (see Note 1) Voltage range applied to any output in the high		\ldots –0.5 V to 7 V
Current into any output in the low state, I _O : SN		
Input clamp current, I_{IK} (V _I < 0)		
Output clamp current, I _{OK} (V _O < 0)		
Package thermal impedance, θ_{JA} (see Note 2):	: DB package	115°C/W
	DW package	
	N package	
		128°C/W
Storage temperature range, T _{stg}		

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions (see Note 3)

			SN54A	BT374	SN74AB	UNIT	
			MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage		4.5	5.5	4.5	5.5	V
VIH	/IH High-level input voltage				2		V
VIL	/IL Low-level input voltage			0.8		0.8	V
VI	I Input voltage			VCC	0	VCC	V
ЮН	High-level output current			-24		-32	mA
IOL	Low-level output current			48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		5		5	ns/V
Т _А	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEOT CONDITIONS		T _A = 25°C			SN54A	BT374	SN74AB			
PARAMETER	TEST CONDITIONS			MIN	TYP [†]	MAX	MIN	MAX	MIN	MAX	UNIT
VIK	V _{CC} = 4.5 V,	lı = -18 mA				-1.2		-1.2		-1.2	V
	V _{CC} = 4.5 V,	I _{OH} = –3 mA		2.5			2.5		2.5		
	V _{CC} = 5 V,	I _{OH} = –3 mA		3			3		3		V
VOH		I _{OH} = -24 mA		2			2				v
	V _{CC} = 4.5 V	I _{OH} = -32 mA		2*					2		
		I _{OL} = 48 mA				0.55		0.55			v
VOL	$V_{CC} = 4.5 \text{ V}$ $I_{OL} = 64 \text{ mA}$					0.55*				0.55	v
V _{hys}					100						mV
lj	V _{CC} = 5.5 V,	$V_I = V_{CC}$ or GI	ND			±1		±1		±1	μΑ
IOZH	V _{CC} = 5.5 V,	V _O = 2.7 V				10‡		10‡		10‡	μΑ
IOZL	$V_{CC} = 5.5 V,$	$V_{O} = 0.5 V$				-10‡		-10‡		-10‡	μΑ
loff	$V_{CC} = 0,$	$V_I \text{ or } V_O \leq 4.5$	V			±100				±100	μΑ
ICEX	V _{CC} = 5.5 V,	V _O = 5.5 V	Outputs high			50		50		50	μΑ
١ _O §	V _{CC} = 5.5 V,	V _O = 2.5 V		-50	-100	-180	-50	-180	-50	-180	mA
		_	Outputs high			250		250		250	μΑ
ICC	$V_{CC} = 5.5 V, I_{C}$ $V_{I} = V_{CC} \text{ or } G$		Outputs low			30		30		30	mA
			Outputs disabled			250		250		250	μΑ
${}^{\Delta I}CC^{\P}$	V_{CC} = 5.5 V, One input at 3.4 V, Other inputs at V _{CC} or GND				1.5		1.5		1.5	mA	
Ci	VI = 2.5 V or 0.	.5 V			3.5						pF
Co	$V_{O} = 2.5 V \text{ or } 0$	0.5 V			6.5						pF

* On products compliant to MIL-PRF-38535, this parameter does not apply.

[†] All typical values are at $V_{CC} = 5$ V. [‡] This data sheet limit may vary among suppliers.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54A	BT374			
			V _{CC} = 5 V, T _A = 25°C		MIN	MAX	UNIT
			MIN	MAX			
fclock	Clock frequency		0	150	0	150	MHz
tw	Pulse duration	CLK high or low	3.3		3.3		ns
+	Satur time before CLK [↑]	Data high	2		2.5		ns
t _{su}	Setup time before CLK↑	Data low	2		2.5		115
t _h	Hold time after CLK↑	Data high or low	2		2.5		ns



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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

				SN74ABT374A				
			V _{CC} =	= 5 V, 25°C	MIN	МАХ	UNIT	
			MIN	MAX				
fclock	Clock frequency		0	150	0	150	MHz	
tw	Pulse duration	CLK high or low	3.3		3.3		ns	
+	Setup time before CLK↑	Data high	1		1		ns	
t _{su}	Setup time before CLK	Data low	1.9		1.9		115	
th	Hold time after CLK↑	Data high or low	2.1†		2.1†		ns	

[†] This data sheet limit may vary among suppliers.

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

			SN54ABT374					
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 5 V, T _A = 25°C		V _{CC} = 5 V, T _A = 25°C MIN MAX		МАХ	UNIT
			MIN	TYP	MAX			
fmax			150	200		150		MHz
^t PLH	CLK	Q	2.2	4.2	5.7	1.8	6.6	ns
^t PHL		Q L	3.1	5.1	6.6	2.6	7.6	115
^t PZH		Q	1.2	3.2	4.7	0.8	5.7	ns
tPZL	OE	Q	2.3	4.7	6.2	1.5	7.2	115
^t PHZ	ŌĒ	Q	2.3	4.5	6.1	1.3	7.2	ns
^t PLZ	UE	2	1.9	4.5	6	1	7	115

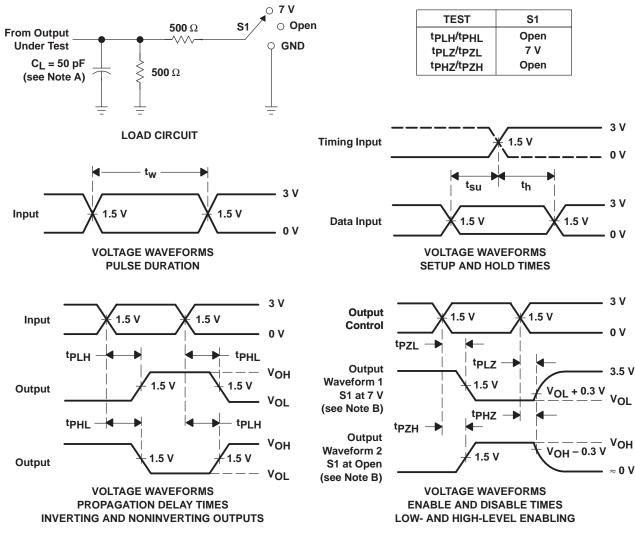
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_1 = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

			SN74ABT374A			'4A		
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V(T/	CC = 5 V A = 25°C	!, ;	MIN	UNIT	
			MIN	TYP	MAX			
fmax			150	200		150		MHz
^t PLH	CLK	Q	2.2	4.2	5.7	2.2	6.2	ns
^t PHL		Q	3.1	5.1	6.6	3.1	7.1	115
^t PZH		Q	1.2	3.2	4.7	1.2	5.2	ns
^t PZL	ŌĒ	Q	2.7	4.7	6.2	2.7	6.7	115
^t PHZ	05	Q	2.5	4.5	6	2.5	6.7†	ns
^t PLZ	OE	2	2	4.5	6	2	6.5	115

[†]This data sheet limit may vary among suppliers.



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns. t_f \leq 2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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